

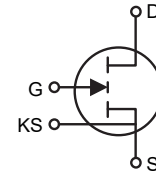
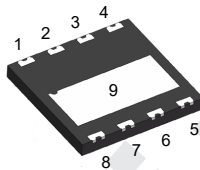
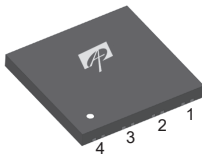
Features

- 650V GaN enhancement-mode transistor
- Normally-off design
- No Qrr (reverse recovery charge)
- Low Qg (gate charge), low Qoss (output charge)
- Integrated ESD protection

Applications

- AC/DC and DC/DC converters, BCM/DCM totem pole PFC, fast battery charging, high density and high efficiency power conversion

Pin Configuration



Pin Information

Gate	Drain	Kelvin Source	Source
8	1, 2, 3, 4	7	5, 6, 9

Ordering Information

Ordering Part Number	Package Type	Form	Shipping Quantity
AONV080V65GA1	DFN8x8	Tape and Reel	1500

Absolute Maximum Ratings

(T_J = 25°C, unless otherwise noted)

Symbol	Parameter		AONV080V65GA1	Units
V _{DS, max}	Drain Source Voltage	V _{GS} = 0V, T _J = -55°C to 150°C	650	V
V _{DS, trans}	Drain Source Voltage Transient ⁽¹⁾	V _{GS} = 0V	800	
V _{DS, pulse}	Drain Source Voltage Pulsed ⁽²⁾	T _J = 25°C, total time < 10 hours T _J = 125°C, total time < 1 hour	750	
I _D	Continuous Drain Current	T _C = 25°C	29	A
I _{D, pulse}	Pulsed Drain Current ⁽³⁾	T _C = 25°C, V _{GS} = 6V, t _{pulse} = 10μs	58	
		T _C = 125°C, V _{GS} = 6V, t _{pulse} = 10μs	29	
V _{GS}	Gate Source Voltage, Continuous ⁽⁴⁾	T _J = -55°C to 150°C	-6 to 7	V
V _{GS, pulse}	Gate Source Voltage, Pulsed	T _J = -55°C to 150°C, t _{pulse} = 50ns, f = 100kHz, open drain	-20 to 10	V
P _{tot}	Power Dissipation ⁽⁵⁾	T _C = 25°C	188	W
T _{J, stg}	Operating and Storage Temperature		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typ	Max	Note	Units
$R_{\theta JA}$	Thermal Resistance Junction-to-Ambient ⁽⁶⁾	33.6			°C/W
$R_{\theta JC}$	Thermal Resistance Junction-to-Case	0.52			°C/W
T_{sold}	Maximum Reflow Soldering Temperature	260		MSL3	°C

Electrical Characteristics

($T_J = 25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units		
STATIC PARAMETERS								
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 30.7\text{mA}$	$T_J = 25^{\circ}\text{C}$	1.2	1.7	2.5	V	
			$T_J = 150^{\circ}\text{C}$		1.6			
I_{DSS}	Drain-Source Leakage Current	$V_{DS} = 650\text{V}$, $V_{GS} = 0\text{V}$	$T_J = 25^{\circ}\text{C}$		5	65	μA	
			$T_J = 150^{\circ}\text{C}$		13	390		
I_{GSS}	Gate-Source Leakage Current	$V_{GS} = 6\text{V}$, $V_{DS} = 0\text{V}$			163		μA	
$R_{DS(on)}$	Drain-Source On-State-Resistance	$V_{GS} = 6\text{V}$, $I_D = 8\text{A}$	$T_J = 25^{\circ}\text{C}$		60	80	m Ω	
			$T_J = 150^{\circ}\text{C}$		135			
R_G	Gate Resistance	$f = 5\text{ MHz}$; open drain			3		Ω	
DYNAMIC								
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V}$, $V_{DS} = 400\text{V}$, $f = 100\text{kHz}$			225		pF	
C_{oss}	Output Capacitance				70			
C_{rss}	Reverse Transfer Capacitance				0.5			
$C_{o(er)}$	Effective Output Capacitance Energy Related ⁽⁷⁾	$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{ to }400\text{V}$			105		pF	
$C_{o(tr)}$	Effective Output Capacitance Time Related ⁽⁸⁾				150			
Q_{oss}	Output Charge				60			nC
$t_{d(on)}$	Turn-On Delay Time		$V_{DS} = 400\text{V}$, $I_D = 16\text{A}$, $L = 318\mu\text{H}$, $V_{GS} = 6\text{V}$, $R_{on} = 10\Omega$, $R_{off} = 2\Omega$, See Figure 20			3		
$t_{d(off)}$	Turn-Off Delay Time				5			
t_r	Rise Time				4			
t_f	Fall Time				4			
GATE CHARGE								
Q_G	Gate Charge	$V_{GS} = 0\text{ to }6\text{V}$, $V_{DS} = 400\text{V}$, $I_D = 8\text{A}$			6.2		nC	
Q_{GS}	Gate-Source Charge				0.5			
Q_{GD}	Gate-Drain Charge				2.2			
V_{Plat}	Gate Plateau Voltage	$V_{DS} = 400\text{V}$, $I_D = 8\text{A}$			2.2		V	

Electrical Characteristics (Continued)

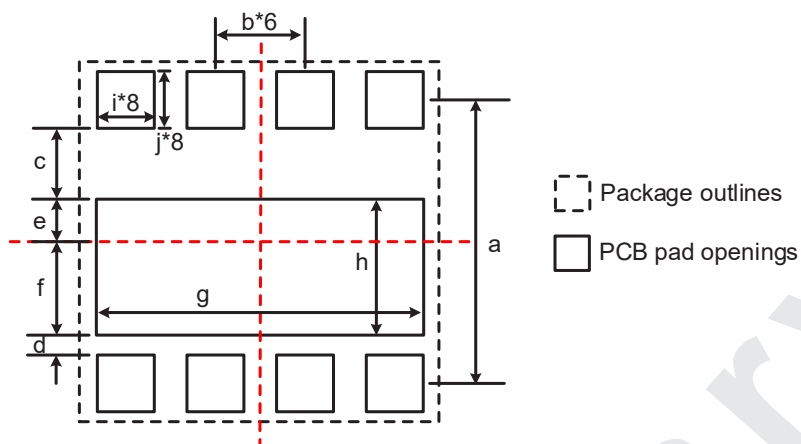
($T_J = 25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
REVERSE CONDUCTION						
V_{SD}	Source-Drain Reverse Voltage	$V_{GS} = 0V, I_S = 8A$		2.3		V
$I_{S, pulse}$	Reverse Pulsed Current	$V_{GS} = 6V, t_{pulse} = 10\mu s$			58	A
Q_{rr}	Reverse Recovery Charge	$I_S = 8A, V_{DS} = 400V$		0		nC
t_{rr}	Reverse Recovery Time			0		ns
I_{rrm}	Peak Reverse Recovery Current			0		A

Notes:

- $V_{DS, transient}$ is intended for non-repetitive events, $t_{PULSE} < 200\mu s$.
- $V_{DS, pulse}$ is intended for repetitive pulse, $t_{PULSE} < 100ns$.
- Limit was extracted from characterization test, not measured during production.
- The minimum V_{GS} is clamped by ESD protection circuit, as shown in Figure 8.
- Power dissipation, and consequently max. current ratings are obtained using max. thermal resistance and max. temperature of 150°C .
- $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2oz copper on FR4 board.
- $C_{o(er)}$ is the fixed capacitance that gives the same stored energy as C_{oss} while VDS is rising from 0 to 400V.
- $C_{o(tr)}$ is the fixed capacitance that gives the same charging time as C_{oss} while VDS is rising from 0 to 400V.

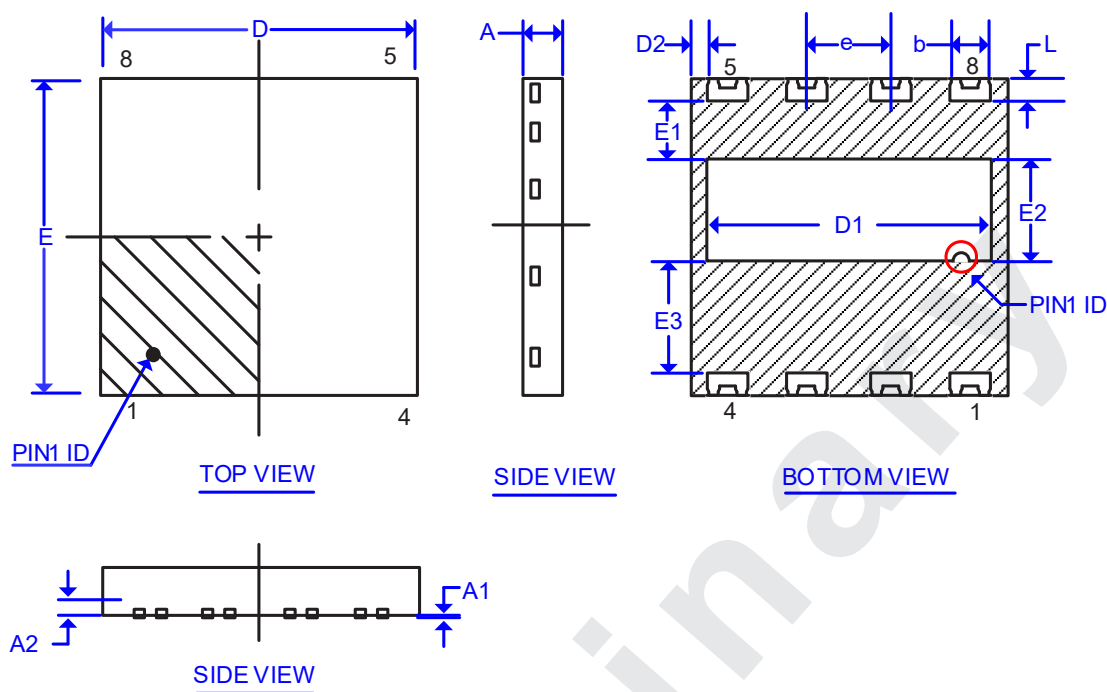
Recommended PCB Footprint



SYMBOL	DIMENSION	SYMBOL	DIMENSION
a	7.800	f	2.750
b	2.000	g	7.500
c	2.325	h	3.700
d	0.525	i	1.400
e	0.950	j	1.250

Notes:
 (1) All dimension are in millimeters.
 (2) Drawing is not to scale.

Package Dimensions, DFN8x8

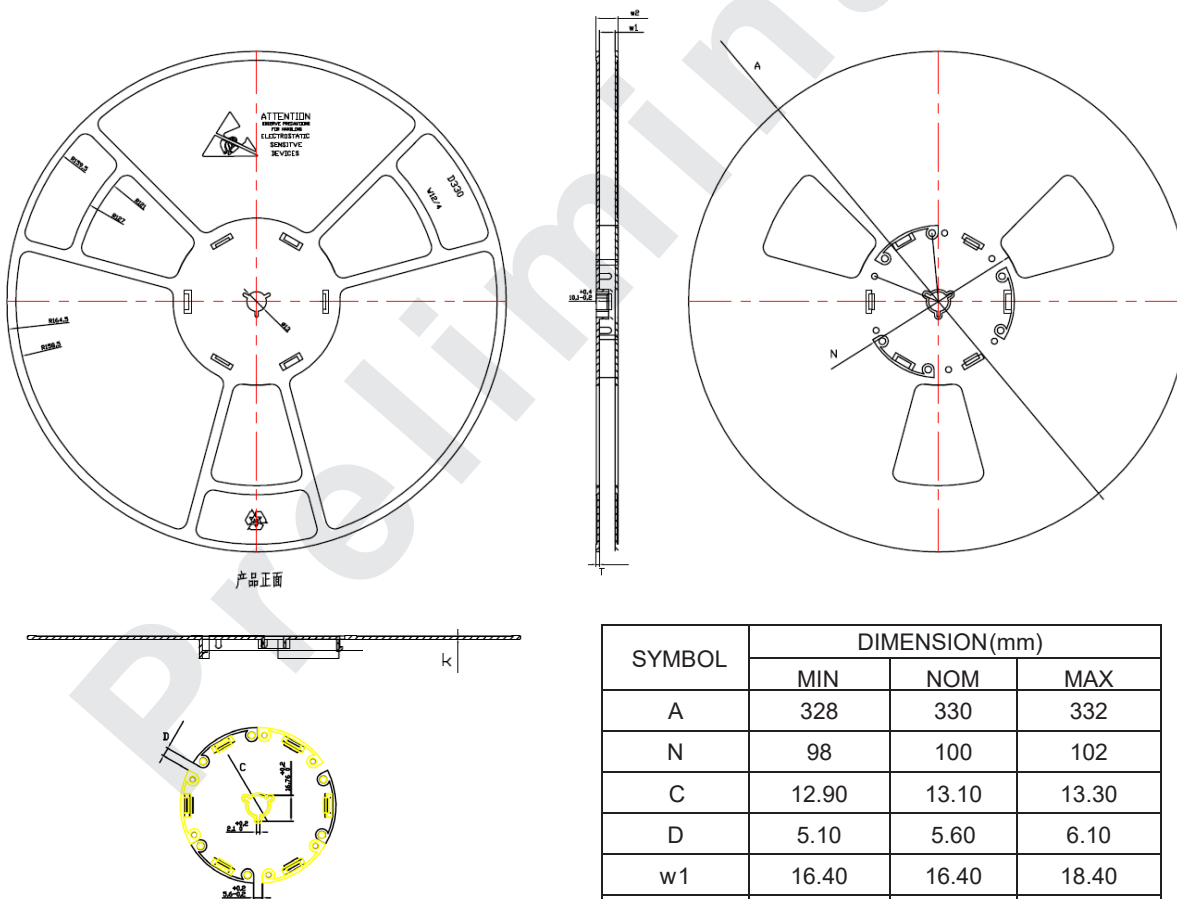
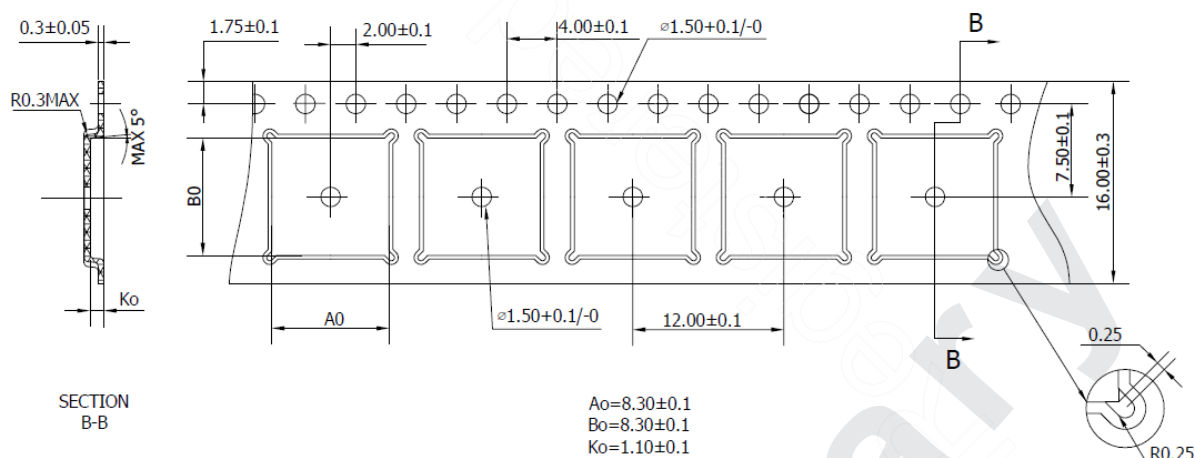


SYMBOL	DIMENSION			SYMBOL	DIMENSION		
	MIN	NOM	MAX		MIN	NOM	MAX
A	0.80	0.90	1.00	E	8.00 B.S.C		
A1	0.00	0.02	0.05	E1	0.90	1.00	1.10
A2	---	0.203 ref	---	E2	3.10	3.20	3.30
b	0.92	1.00	1.05	E3	2.70	2.80	2.90
D	8.00 B.S.C			e	2.00 B.S.C		
D1	6.84	6.94	7.04	L	0.40	0.50	0.60
D2	0.40	0.50	0.60				

Notes:

- (1) Dimension and tolerance conform to ASME Y14.5-2009.
- (2) All dimension are in millimeters.
- (3) Lead coplanarity shall be 0.1 millimeters max.
- (4) Complies with JEDEC MO-229.
- (5) Drawing is not to scale.
- (6) Dimensions do not include mold protrusion.
- (7) Package outline exclusive of metal burr dimensions.

Tape and Reel Dimensions, DFN8x8



SYMBOL	DIMENSION(mm)		
	MIN	NOM	MAX
A	328	330	332
N	98	100	102
C	12.90	13.10	13.30
D	5.10	5.60	6.10
w1	16.40	16.40	18.40
w2	20.60	20.60	22.60
T	1.95	2.10	2.25
K	1.30	1.40	1.55

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2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.